

## STD40N2LH5 STU40N2LH5

### N-channel 25 V, 0.01 Ω, 40 A, DPAK, IPAK STripFET™ V Power MOSFET

Preliminary Data

### **Features**

Туре	V <sub>DSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>
STD40N2LH5	25 V	0.012 Ω	40 A
STU40N2LH5	25 V	0.0126 Ω	40 A

- R<sub>DS(on)</sub> \* Q<sub>g</sub> industry benchmark
- Extremely low on-resistance R<sub>DS(on)</sub>
- Very low switching gate charge
- High avalanche ruggedness
- Low gate drive power losses



Switching applications



This product utilizes the 5<sup>th</sup> generation of design rules of ST's proprietary STripFET<sup>TM</sup> technology. The lowest available  $R_{DS(on)}^*Q_g$ , in the standard packages, makes this device suitable for the most demanding DC-DC converter applications, where high power density is to be achieved.

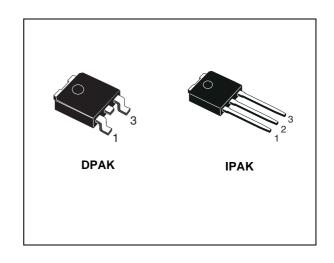


Figure 1. Internal schematic diagram

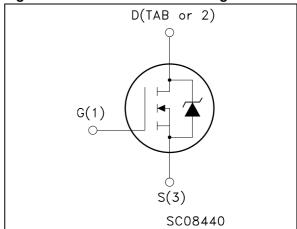


Table 1. Device summary

Order codes	Marking	Package	Packaging
STD40N2LH5	40N2LH5	DPAK	Tape and reel
STU40N2LH5	40N2LH5	IPAK	Tube

# 1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage (V <sub>GS</sub> =0)	25	V
V <sub>GS</sub>	Gate-Source voltage	± 22	V
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 25 °C	40	А
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 100 °C	28	Α
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed)	160	Α
P <sub>TOT</sub>	Total dissipation at T <sub>C</sub> = 25 °C	35	W
	Derating factor	0.23	W/°C
E <sub>AS</sub> (2)	Single pulse avalanche energy	TBD	mJ
T <sub>j</sub> T <sub>stg</sub>	Operating junction temperature Storage temperature	-55 to 175	°C

<sup>1.</sup> Pulse width limited by safe operating area

Table 3. Thermal resistance

Symbol	Parameter	Value	Unit
Rthj-case	Thermal resistance junction-case max	4.3	°C/W
Rthj-amb	Thermal resistance junction-case max	100	°C/W
T <sub>I</sub>	Maximum lead temperature for soldering purpose	275	°C

<sup>2.</sup> Starting Tj = 25 °C,  $I_D$  = 24 A,  $V_{DD}$  = 12 V

### 2 Electrical characteristics

 $(T_{CASE} = 25^{\circ}C \text{ unless otherwise specified})$ 

Table 4. Static

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown Voltage	$I_D = 250 \ \mu\text{A}, \ V_{GS} = 0$	25			V
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = 25 V V <sub>DS</sub> = 25 V, T <sub>C</sub> = 125 °C			1 10	μA μA
I <sub>GSS</sub>	Gate body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 22 V			±100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1			٧
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A SMD version		0.01	0.012	Ω
Brack	R <sub>DS(on)</sub> Static drain-source on resistance	$V_{GS}$ = 10 V, $I_{D}$ = 20 A		0.0106	0.0126	Ω
nDS(on)		V <sub>GS</sub> = 5 V, I <sub>D</sub> = 20 A SMD version		0.0135	0.017	Ω
		$V_{GS} = 5 \text{ V}, I_D = 20 \text{ A}$		0.0141	0.0176	Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min	Тур.	Max.	Unit
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25 \text{ V, f=1 MHz,}$ $V_{GS} = 0$		840 180 29		pF pF pF
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total gate charge Gate-source charge Gate-drain charge	$V_{DD}$ =15 V, $I_D$ = 40 A $V_{GS}$ = 5 V (Figure 3)		8 TBD TBD		nC nC nC
Q <sub>gs1</sub>	Pre V <sub>th</sub> gate-to-source charge Post V <sub>th</sub> gate-to-source charge	$V_{DD}$ =15 V, $I_D$ = 40 A $V_{GS}$ = 5 V (Figure 8)		TBD TBD		nC nC
R <sub>G</sub>	Gate input resistance	f=1 MHz gate bias Bias= 0 test signal level=20 mV open drain		1.1		Ω

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Table 6. Switching on/off (resistive load)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub> t <sub>r</sub>	Turn-on delay time Rise time	$V_{DD}$ = 10 V, $I_{D}$ = 20 A, $R_{G}$ = 4.7 $\Omega$ , $V_{GS}$ = 10 V (Figure 2 and Figure 7)		TBD TBD		ns ns
t <sub>d(off)</sub>	Turn-off delay time Fall time	$V_{DD}$ = 10 V, $I_{D}$ = 20 A, $R_{G}$ = 4.7 $\Omega$ , $V_{GS}$ = 10 V (Figure 2 and Figure 7)		TBD TBD		ns ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub> I <sub>SDM</sub>	Source-drain current Source-drain current (pulsed) <sup>(1)</sup>				40 160	A A
V <sub>SD</sub>	Forward on voltage	I <sub>SD</sub> = 20 A, V <sub>GS</sub> =0			1.1	٧
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD}$ = 40 A, di/dt =100 A/ $\mu$ s, $V_{DD}$ = 20 V, Tj = 25 °C (Figure 4)		TBD TBD TBD		ns nC A

<sup>1.</sup> Pulsed: pulse duration = 300µs, duty cycle 1.5%

### 3 Test circuits

Figure 2. Switching times test circuit for resistive load

Figure 3. Gate charge test circuit

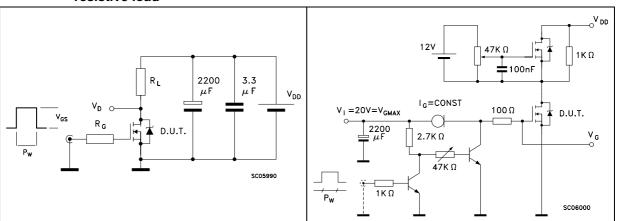


Figure 4. Test circuit for inductive load switching and diode recovery times

Figure 5. Unclamped Inductive load test circuit

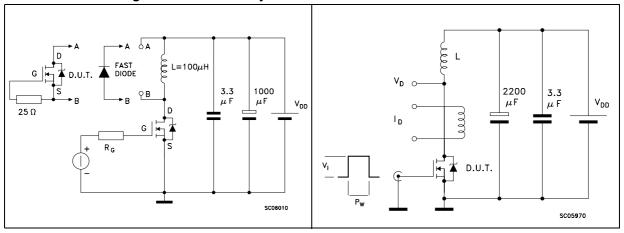
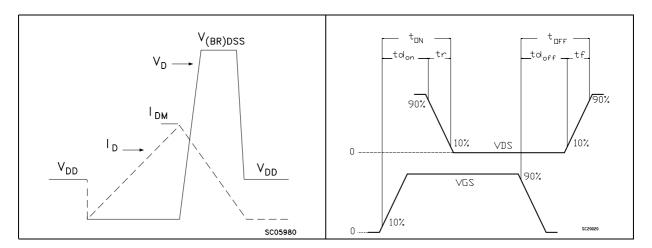


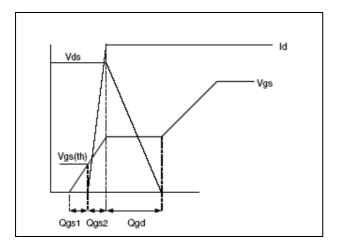
Figure 6. Unclamped inductive waveform

Figure 7. Switching time waveform



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Figure 8. Gate charge waveform



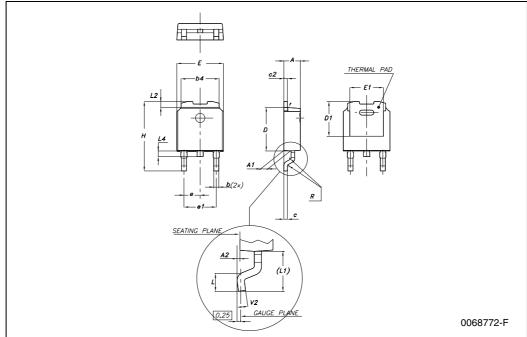
### 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: <a href="https://www.st.com">www.st.com</a>

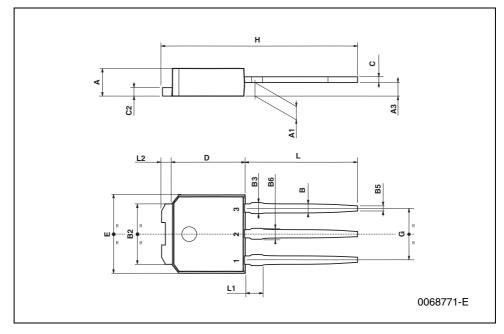
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### **DPAK MECHANICAL DATA**

DIM		mm.			inch	
DIM.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
Α	2.2		2.4	0.086		0.094
A1	0.9		1.1	0.035		0.043
A2	0.03		0.23	0.001		0.009
В	0.64		0.9	0.025		0.035
b4	5.2		5.4	0.204		0.212
С	0.45		0.6	0.017		0.023
C2	0.48		0.6	0.019		0.023
D	6		6.2	0.236		0.244
D1		5.1			0.200	
Е	6.4		6.6	0.252		0.260
E1		4.7			0.185	
е		2.28			0.090	
e1	4.4		4.6	0.173		0.181
Н	9.35		10.1	0.368		0.397
L	1			0.039		
(L1)		2.8			0.110	
L2		0.8			0.031	
L4	0.6		1	0.023		0.039
R		0.2			0.008	
V2	0°		8°	0°		8°



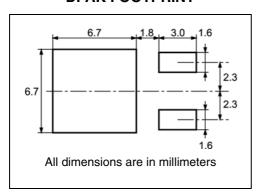
DIM.		mm			inch	
DIWI.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
Α	2.2		2.4	0.086		0.094
A1	0.9		1.1	0.035		0.043
А3	0.7		1.3	0.027		0.051
В	0.64		0.9	0.025		0.031
B2	5.2		5.4	0.204		0.212
В3			0.85			0.033
B5		0.3			0.012	
B6			0.95			0.037
С	0.45		0.6	0.017		0.023
C2	0.48		0.6	0.019		0.023
D	6		6.2	0.236		0.244
Е	6.4		6.6	0.252		0.260
G	4.4		4.6	0.173		0.181
Н	15.9		16.3	0.626		0.641
L	9		9.4	0.354		0.370
L1	0.8		1.2	0.031		0.047
L2		0.8	1		0.031	0.039



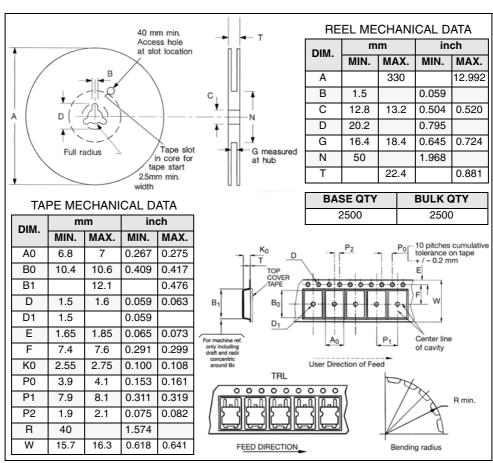
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### 5 Packaging mechanical data

#### **DPAK FOOTPRINT**



#### **TAPE AND REEL SHIPMENT**



# 6 Revision history

Table 8. Document revision history

Date	Revision	Changes
24-Jul-2008	1	Initial release
23-Sep-2008	2	V <sub>GS</sub> value has been changed on <i>Table 2</i> and <i>Table 5</i>

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